

## Question Paper Code: 40971

## B.E./B.Tech. DEGREE EXAMINATION, APRIL/MAY 2018

Seventh Semester

Electronics and Communication Engineering
EC 6701 – RF AND MICROWAVE ENGINEERING

(Regulations 2013)

Time: Three Hours

Maximum: 100 Marks

Smith Chart should be provided

Answer ALL questions

PART - A

 $(10\times2=20 \text{ Marks})$ 

- 1. State the applications of RF circuit.
- 2. What are the reasons that low frequency parameters cannot be measured in microwaves?
- 3. Define matching network.
- 4. What is the need of Rollett factor, K? Write its expressions.
- 5. State Faraday's rotation law.
- 6. State the two parameters that describe a directional coupler? Define them.
- 7. What is velocity modulation?
- 8. What is the purpose of slow wave structures in TWT? Name them.
- 9. What is the significance of VSWR measurement?
- 10. List any two methods of measuring microwave power.

PART - B

 $(5\times16=80 \text{ Marks})$ 

11. a) Derive the properties of scattering matrix.

(16)

(OR)

b) i) How microwave junction can be described by scattering matrix? Derive the scattering matrix relation between the input and output of  $n \times n$  junction. (10)

ii) Describe the losses in microwave devices.

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a) Derive the properties of southering outling

(8)

(8)

b) i) Draw the experimental set-up for the measurement of impedance of a

ii) Draw the experimental set-up for S-parameter measurement of Magic

ii) Explain a method for high power measurement.

discontinuity and explain.

Tee and explain.